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	Application No.	Applicant(s)	
Notice of Allowability	09/815,282	NAGAI ET AL.	
	Examiner	Art Unit	
	Paul Gurzo	2881	
The MAILING DATE of this communication appears on the cover sheet with the correspondence address All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.			
1. This communication is responsive to 6/1/04.			
2. The allowed claim(s) is/are <u>1-25</u> .			
3. The drawings filed on 16 July 2003 are accepted by the Examiner.			
<ul> <li>4.  Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). <ul> <li>a)  All b)  Some* c) None of the:</li> <li>1.  Certified copies of the priority documents have been received.</li> <li>2.  Certified copies of the priority documents have been received in Application No</li> <li>3.  Copies of the certified copies of the priority documents have been received in this national stage application from the International Bureau (PCT Rule 17.2(a)).</li> <li>* Certified copies not received:</li> </ul> </li> <li>Applicant has THREE MONTHS FROM THE "MAILING DATE" of this communication to file a reply complying with the requirements noted below. Failure to timely comply will result in ABANDONMENT of this application.  THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.</li> <li>5.  A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient.</li> <li>6.  CORRECTED DRAWINGS (as "replacement sheets") must be submitted.  (a)  including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached  1)  hereto or 2)  Draper No./Mail Date  (b)  including changes required by the attached Examiner's Amendment / Comment or in the Office action of Paper No./Mail Date  Identifying indicia such as the application number (see 37 CFR 1.84(c)) should be written on the drawings in the front (not the back) of each sheet. Replacement sheet(s) should be labeled as such in the header according to 37 CFR 1.121(d).</li> <li>7.  DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.</li> </ul>			
Attachment(s)  1. ☑ Notice of References Cited (PTO-892)  2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948)  3. ☐ Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date  4. ☐ Examiner's Comment Regarding Requirement for Deposit of Biological Material	6. Interview S Paper No 8), 7. Examiner's	nformal Patent Application (PTC Summary (PTO-413), /Mail Date s Amendment/Comment s Statement of Reasons for Allo 	

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## **DETAILED ACTION**

## Allowable Subject Matter

Claims 1-25 are allowed.

The following is an examiner's statement of reasons for allowance: As the claimed invention was read in light of the specification, the prior art of record fails to disclose or render obvious a method of controlling a scanning electron microscope comprising the steps of irradiating a surface of an object with a primary beam swept, in a scanning direction, over a fixed scanning range length and detecting secondary electrons released from the object due to the irradiation during a predetermined period constituting a portion of a fixed primary electron beam scanning time, the primary electron beam scanning time comprising a single sweep of the primary electron beam in the scanning direction over a fixed scanning range length, wherein the predetermined period is changed depending on a magnification for observing the object, without changing a scanning rate of the primary electron beam across the surface of the object.

The closest prior art, Otaka et al. (5,412,209) and Nakagaki et al. (6,476,388), teach a scanning electron microscope that irradiates a surface and detects secondary electrons at a high and low magnification but do not teach a single sweep of the primary electron beam during a predetermined period because the period varies with the square of the magnification. In addition, Applicant's arguments dated 6/1/04 are persuasive (See page 9, paragraph 3 - page 10, paragraph 5).

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue

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fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for

Allowance."

Conclusion

The prior art made of record and not relied upon is considered pertinent to applicant's

disclosure.

Todokoro et al. (5,276,325)

Any inquiry concerning this communication or earlier communications from the

examiner should be directed to Paul Gurzo whose telephone number is (571) 272-2472. The

examiner can normally be reached on M-Fri. 7:30 - 6:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's

supervisor, John Lee can be reached at (571) 272-2477. The fax phone numbers for the

organization where this application or proceeding is assigned are (703) 872-9306 for regular

communications and (703) 872-9306 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding

should be directed to the receptionist whose telephone number is (703) 308-0956.

**PMG** 

July 9, 2004

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